PROCEEDINGS OF SPIE

Real-time Photonic Measurements, Data Management, and Processing

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9–11 October 2014 Beijing, China

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Published by SPIE

Volume 9279

Proceedings of SPIE 0277-786X, V. 9279

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

Real-time Photonic Measurements, Data Management, and Processing, edited by Bahram Jalali, Ming Li, Keisuke Goda, Mohammad Hossein Asghari, Proc. of SPIE Vol. 9279, 927901 · © 2014 SPIE CCC code: 0277-786X/14/\$18 · doi: 10.1117/12.2181568 The papers included in this volume were part of the technical conference cited on the cover and title page. Papers were selected and subject to review by the editors and conference program committee. Some conference presentations may not be available for publication. The papers published in these proceedings reflect the work and thoughts of the authors and are published herein as submitted. The publisher is not responsible for the validity of the information or for any outcomes resulting from reliance thereon.

Please use the following format to cite material from this book:

Author(s), "Title of Paper," in Real-time Photonic Measurements, Data Management, and Processing, edited by Bahram Jalali, Ming Li, Keisuke Goda, Mohammad Hossein Asghari, Proceedings of SPIE Vol. 9279 (SPIE, Bellingham, WA, 2014) Article CID Number.

ISSN: 0277-786X ISBN: 9781628413526

Published by **SPIE** P.O. Box 10, Bellingham, Washington 98227-0010 USA Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445 SPIE.org

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